PSMN039-100YS

N-channel LFPAK 100 V 39.5 mΩ standard level MOSFET

Rev. 02 — 2 April 2010

Product data sheet

1. Product profile

1.1 General description

Standard level N-channel MOSFET in LFPAK package qualified to 175 °C. This product is designed and qualified for use in a wide range of industrial, communications and domestic equipment.

1.2 Features and benefits

- Advanced TrenchMOS provides low RDSon and low gate charge
- High efficiency gains in switching power converters
- Improved mechanical and thermal characteristics
- LFPAK provides maximum power density in a Power SO8 package

1.3 Applications

- DC-to-DC converters
- Lithium-ion battery protection
- Load switching

- Motor control
- Server power supplies

1.4 Quick reference data

Table 1. Quick reference

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	-	100	V
I _D	drain current	T_{mb} = 25 °C; V_{GS} = 10 V; see <u>Figure 1</u>	-	-	28.1	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	-	74	W
Tj	junction temperature		-55	-	175	°C
Avalanc	he ruggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	$V_{GS} = 10 \text{ V}; T_{j(init)} = 25 \text{ °C};$ $I_{D} = 28.1 \text{ A}; V_{sup} \le 100 \text{ V};$ unclamped; $R_{GS} = 50 \Omega$	-	-	42	mJ
Dynamic	characteristics					
Q_{GD}	gate-drain charge	$V_{GS} = 10 \text{ V}; I_D = 15 \text{ A};$	-	8	-	nC
$Q_{G(tot)} \\$	total gate charge	V _{DS} = 50 V; see <u>Figure 14</u> and <u>15</u>	-	23	-	nC



Table 1. Quick reference ...continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static ch	aracteristics					
R _{DSon}	drain-source on-state resistance	$V_{GS} = 10 \text{ V; } I_D = 15 \text{ A;}$ $T_j = 100 \text{ °C; see } \frac{\text{Figure 12}}{\text{ occ}}$	-	-	71	mΩ
		$V_{GS} = 10 \text{ V; } I_D = 15 \text{ A;}$ $T_j = 25 \text{ °C; see } \frac{\text{Figure } 13}{\text{ Figure } 13}$	-	30.8	39.5	mΩ

2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source		_
2	S	source	mb (D
3	S	source		
4	G	gate	Q	<u> </u>
mb	D	mounting base; connected to drain	1 2 3 4	mbb076 Ś
			SOT669 (LFPAK)	

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
PSMN039-100YS	LFPAK	plastic single-ended surface-mounted package (LFPAK); 4 leads	SOT669

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$	-	100	V
V_{DGR}	drain-gate voltage	$T_j \le 175 \text{ °C}; T_j \ge 25 \text{ °C}; R_{GS} = 20 \text{ k}\Omega$	-	100	V
V_{GS}	gate-source voltage		-20	20	V
I _D	drain current	V _{GS} = 10 V; T _{mb} = 100 °C; see <u>Figure 1</u>	-	20	Α
		V _{GS} = 10 V; T _{mb} = 25 °C; see <u>Figure 1</u>	-	28.1	Α
I _{DM}	peak drain current	$t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$; see Figure 3	-	112	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	74	W
T _{stg}	storage temperature		-55	175	°C
Tj	junction temperature		-55	175	°C
T _{sld(M)}	peak soldering temperature		-	260	°C
Source-dr	ain diode				
Is	source current	T _{mb} = 25 °C	-	28.1	Α
I _{SM}	peak source current	$t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$	-	112	Α
Avalanche	ruggedness				
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 28.1 A; V_{sup} ≤ 100 V; unclamped; R_{GS} = 50 Ω	-	42	mJ

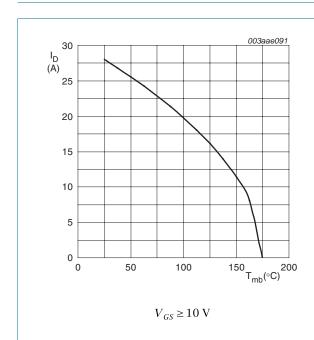


Fig 1. Continuous drain current as a function of mounting base temperature

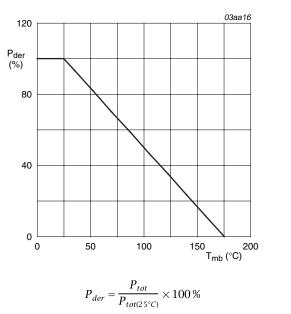
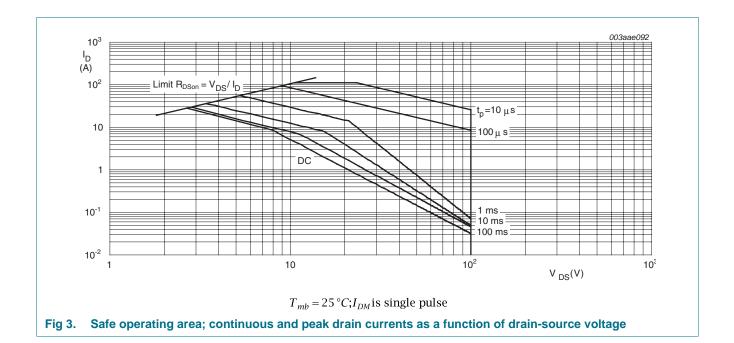


Fig 2. Normalized total power dissipation as a function of mounting base temperature



5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	see Figure 4	-	1	2.03	K/W

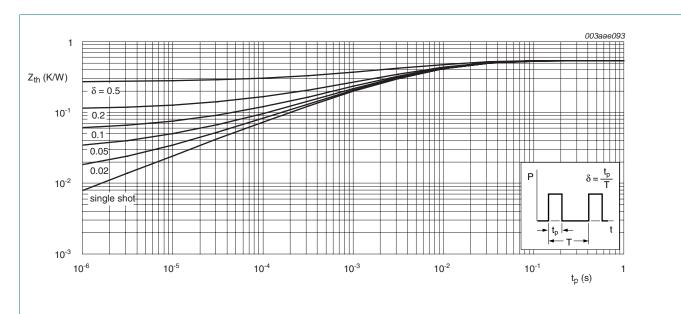


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration; typical values

6. Characteristics

Table 6. Characteristics

Vergios drain-source Dead of the selection De	Symbol	Parameter	Conditions	Min	Tvn	Max	Unit
V(BR)DSS drain-source breakdown voltage I _D = 0.25 mA; V _{GS} = 0 V; T _j = .55 °C 90	Symbol Statio sho	Parameter	Conditions	IVIIII	Тур	IVIAX	Unit
Vos			1 0.05 mA. W 0.16 T 55.00	00			\/
See Figure 12 Vos = 10 V; Vos = 0 V; T ₁ = 125 °C	V _{(BR)DSS}					-	
Voltage See Figure 10 I _D = 1 mA; V _{DS} = V _{GS} ; T _j = 25 °C;						-	<u> </u>
See Figure 11 and 10 not n	V _{GS(th)}	_	,	1	-	-	V
See Figure 10 See Figure 12 Sec See Figure 12 Sec See Figure 12 Sec See Figure 14 See Figure 16 See See Figure 16 See				2	3	4	V
$V_{DS} = 100 \ V; \ V_{GS} = 0 \ V; \ T_j = 25 \ ^{\circ}C \qquad - \qquad 0.01 2 \qquad \mu A$ $V_{DS} = 100 \ V; \ V_{DS} = 0 \ V; \ T_j = 25 \ ^{\circ}C \qquad - \qquad 2 \qquad 100 \qquad nA$ $V_{GS} = 20 \ V; \ V_{DS} = 0 \ V; \ T_j = 25 \ ^{\circ}C \qquad - \qquad 2 \qquad 100 \qquad nA$ $V_{GS} = 20 \ V; \ V_{DS} = 0 \ V; \ T_j = 25 \ ^{\circ}C \qquad - \qquad 2 \qquad 100 \qquad nA$ $V_{GS} = 20 \ V; \ V_{DS} = 0 \ V; \ T_j = 25 \ ^{\circ}C \qquad - \qquad 2 \qquad 100 \qquad nA$ $V_{DS} = 10 \ V; \ V_{DS} = 10 \ V; \ V_{DS} = 100 \ ^{\circ}C; \qquad - \qquad - \qquad 71 \qquad m\Omega$ $V_{DS} = 10 \ V; \ V_{DS} = 10 \ V; \ V_{DS} = 100 \ ^{\circ}C; \qquad - \qquad 72.9 \qquad 100 \qquad m\Omega$ $V_{DS} = 10 \ V; \ V_{DS} = 10 \ V; \ $				-	-	4.7	V
$ \begin{array}{c} l_{GSS} \\ l_{GSS} $	I _{DSS}	drain leakage current	$V_{DS} = 100 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 125 \text{ °C}$	-	-	50	μΑ
$ \begin{array}{c} & V_{GS} = -20 \ V; \ V_{DS} = 0 \ V; \ T_{J} = 25 \ ^{\circ}C \\ & - 2 \\ & 100 \\ &$			V _{DS} = 100 V; V _{GS} = 0 V; T _j = 25 °C	-	0.01	2	μΑ
$ \begin{array}{c} R_{DSon} \\ R_{$	I _{GSS}	gate leakage current	$V_{GS} = 20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	2	100	nA
resistance See Figure 12 V _{GS} = 10 V; l _D = 15 A; T _j = 175 °C; - 72.9 100 mΩ mΩ N _{GS} = 10 V; l _D = 15 A; T _j = 25 °C; - 30.8 39.5 mΩ N _{GS} = 10 V; l _D = 15 A; T _j = 25 °C; - 30.8 39.5 mΩ N _{GS} = 10 V; l _D = 15 A; T _j = 25 °C; - 30.8 39.5 mΩ N _{GS} = 10 V; l _D = 15 A; V _{DS} = 50 V; V _{GS} = 10 V; - 23 - 10 C N _{GS} N _{GS} = 10 V; - 19 - 10 C N _{GS} N _{GS} = 10 V; - 19 - 10 C N _{GS} N _{GS} = 10 V; - 19 - 10 C N _{GS} N _{GS} = 10 V; - 19 - 10 C N _{GS} N _{GS} = 10 V; - 19 - 10 C N _{GS} N _{GS} = 10 V; - 19 - 10 C N _{GS} N _{GS} = 10 V; - 19 - 10 C N _{GS} N _{GS} = 10 V; - 19 - 10 C N _{GS} N _{GS} = 10 V; - 19 - 10 C N _{GS} N _{GS} = 10 V; - 19 - 10 C N _{GS} N _{GS} = 10 V; - 10 N _{GS} N _{GS} = 10 V; - 10 N _{GS} N _{GS} N _{GS} = 10 V; - 10 N _{GS} N _{GS} N _{GS} = 10 V; - 10 N _{GS} N _{GS} N _{GS} = 10 V; - 10 N _{GS} N _{GS} N _{GS} N _{GS} = 10 V; - 10 N _{GS} N _{GS} N _{GS} = 10 V; - 10 N _{GS} N _G			V _{GS} = -20 V; V _{DS} = 0 V; T _j = 25 °C	-	2	100	nA
	R _{DSon}			-	-	71	mΩ
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$			·	-	72.9	100	mΩ
$ \begin{array}{c} \text{(AC)} \\ \text{Dynamic characteristics} \\ \\ Q_{G(tot)} \\ \text{total gate charge} \\ tota$,	-	30.8	39.5	mΩ
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	R _G		f = 1 MHz	-	0.62	1.5	Ω
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Dynamic (characteristics					
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	Q _{G(tot)}	total gate charge		-	23	-	nC
$\begin{array}{cccccccccccccccccccccccccccccccccccc$				-	19	-	nC
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	Q _{GS}	gate-source charge		-	5	-	nC
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	Q _{GS(th)}	pre-threshold		-	3	-	nC
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	Q _{GS(th-pl)}	post-threshold		-	2	-	nC
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	Q_{GD}	<u> </u>		-	8	-	nC
$ \begin{array}{cccccccccccccccccccccccccccccccccccc$	V _{GS(pl)}	•		-	4.5	-	V
$ \begin{array}{cccccccccccccccccccccccccccccccccccc$	C _{iss}	input capacitance	V _{DS} = 50 V; V _{GS} = 0 V; f = 1 MHz;	-	1847	-	pF
$ \begin{array}{c} C_{rss} & \text{reverse transfer} \\ capacitance \\ \hline t_{d(on)} & \text{turn-on delay time} \\ \hline t_r & \text{rise time} \\ \hline t_{d(off)} & \text{turn-off delay time} \\ \hline \end{array} \begin{array}{c} V_{DS} = 50 \text{ V}; \text{ R}_L = 3.3 \ \Omega; \text{ V}_{GS} = 10 \text{ V}; \\ R_{G(ext)} = 4.7 \ \Omega; \text{ T}_j = 25 \ ^{\circ}\text{C} \\ \hline \end{array} \begin{array}{c} - & 64 \\ - & \text{pF} \\ \hline \end{array} $	C _{oss}	<u> </u>	T _j = 25 °C; see <u>Figure 16</u>	-	86	-	pF
$ \begin{array}{cccccccccccccccccccccccccccccccccccc$	C _{rss}	reverse transfer		-		-	-
$R_{G(ext)} = 4.7 \ \Omega; T_j = 25 \ ^{\circ}C$ - 8 - ns turn-off delay time - 22 - ns	t _{d(on)}	•	$V_{DS} = 50 \text{ V}; R_L = 3.3 \Omega; V_{GS} = 10 \text{ V};$	-	11	-	ns
t _{d(off)} turn-off delay time - 22 - ns	t _r	•		-	8	-	ns
G(C)		turn-off delay time		-	22	-	ns
	t _f	<u> </u>		-	7	-	ns

PSMN039-100YS_2

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Table 6. Characteristics ... continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Source-dr	ain diode					
V_{SD}	source-drain voltage	$I_S = 15 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C};$ see <u>Figure 17</u>	-	0.8	1.2	V
t _{rr}	reverse recovery time	$I_S = 5 \text{ A}$; $dI_S/dt = 100 \text{ A/}\mu\text{s}$; $V_{GS} = 0 \text{ V}$;	-	44	-	ns
Qr	recovered charge	$V_{DS} = 50 \text{ V}$	-	78	-	nC

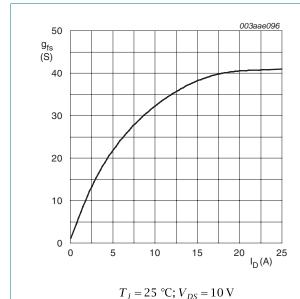


Fig 5. Forward transconductance as a function of drain current; typical values

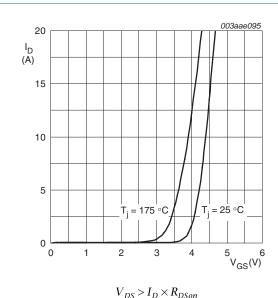


Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values

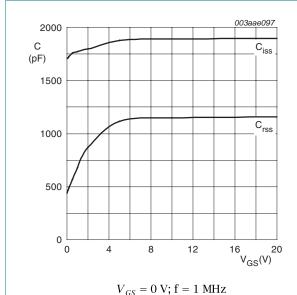


Fig 7. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

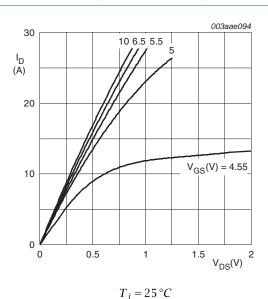


Fig 8. Output characteristics: drain current as a function of drain-source voltage; typical values

PSMN039-100YS_2

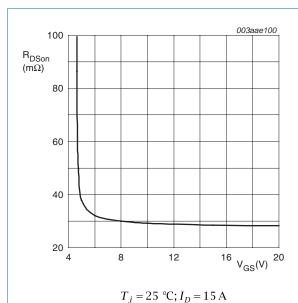
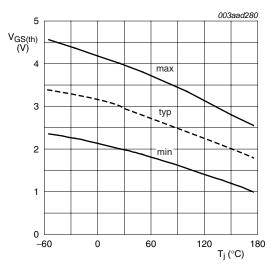


Fig 9. Drain-source on-state resistance as a function of gate-source voltage; typical values



 $I_D = 1$ mA; $V_{DS} = V_{GS}$

Fig 10. Gate-source threshold voltage as a function of junction temperature

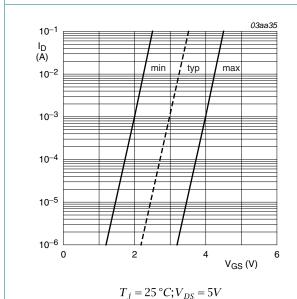
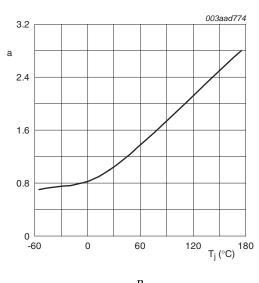


Fig 11. Sub-threshold drain current as a function of gate-source voltage



 $a = \frac{R_{DSon}}{R_{DSon(25\,^{\circ}\text{C})}}$

Fig 12. Normalized drain-source on-state resistance factor as a function of junction temperature

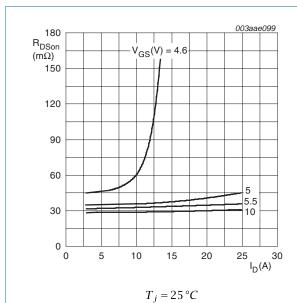


Fig 13. Drain-source on-state resistance as a function of drain current; typical values

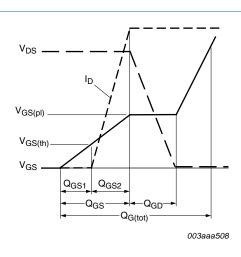


Fig 14. Gate charge waveform definitions

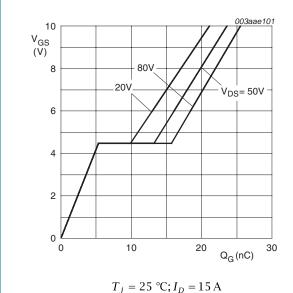


Fig 15. Gate-source voltage as a function of gate charge; typical values

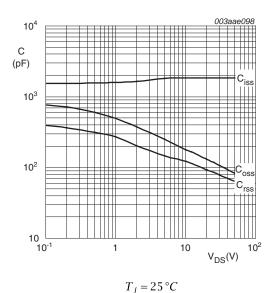


Fig 16. Drain-source on-state resistance as a function of drain current; typical values

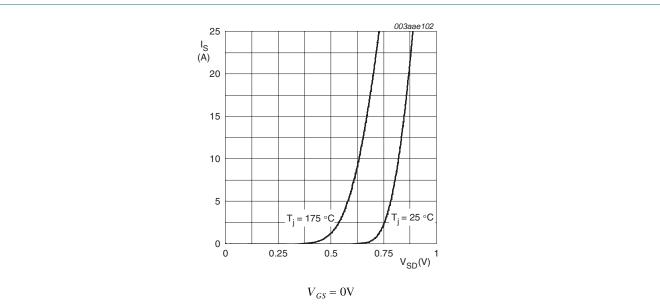
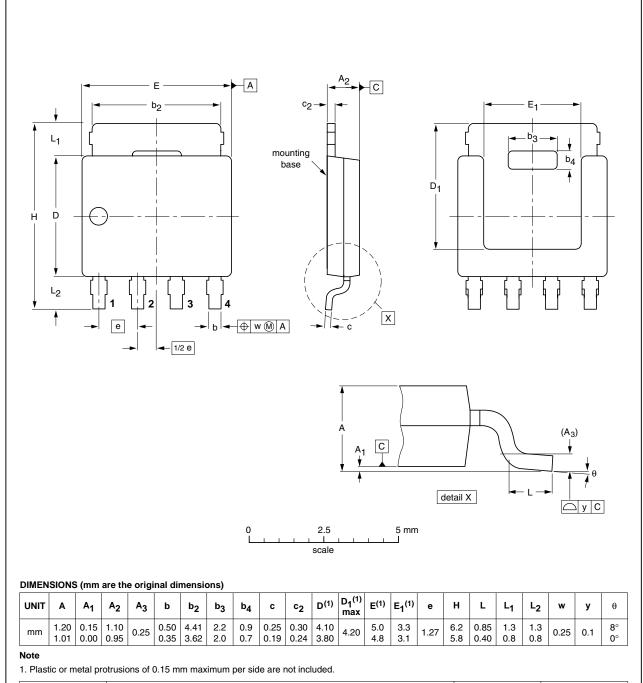


Fig 17. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values

7. Package outline

Plastic single-ended surface-mounted package (LFPAK); 4 leads

SOT669



OUTLINE		REFER	EUROPEAN	ISSUE DATE			
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE	
SOT669		MO-235			$ \ \ \bigoplus \big($	04-10-13 06-03-16	

Fig 18. Package outline SOT669 (LFPAK)

PSMN039-100YS_2

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8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PSMN039-100YS_2	20100402	Product data sheet	-	PSMN039-100YS_1
Modifications:	 Status cha 	roduct.		
PSMN039-100YS_1	20100114	Objective data sheet	-	-

9. Legal information

9.1 Data sheet status

Document status [1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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N-channel LFPAK 100 V 39.5 mΩ standard level MOSFET

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11. Contents

1	Product profile
1.1	General description
1.2	Features and benefits
1.3	Applications
1.4	Quick reference data1
2	Pinning information
3	Ordering information2
4	Limiting values3
5	Thermal characteristics5
6	Characteristics6
7	Package outline
8	Revision history12
9	Legal information13
9.1	Data sheet status
9.2	Definitions13
9.3	Disclaimers
9.4	Trademarks14
10	Contact information

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